



# LOG100

# Precision LOGARITHMIC AND LOG RATIO AMPLIFIER

## **FEATURES**

- ACCURACY
   0.37% FSO max Total Error
   Over 5 Decades
- LINEARITY
   0.1% max Log Conformity
   Over 5 Decades
- EASY TO USE
   Pin-selectable Gains
   Internal Laser-trimmed Resistors
- WIDE INPUT DYNAMIC RANGE 6 Decades, 1nA to 1mA
- HERMETIC CERAMIC DIP

# DESCRIPTION

The LOG100 uses advanced integrated circuit technologies to achieve high accuracy, ease of use, low cost, and small size. It is the logical choice for your logarithmic-type computations. The amplifier has guaranteed maximum error specifications over the full sixdecade input range (1nA to 1mA) and for all possible combinations of  $I_1$  and  $I_2$ . Total error is guaranteed so that involved error computations are not necessary.

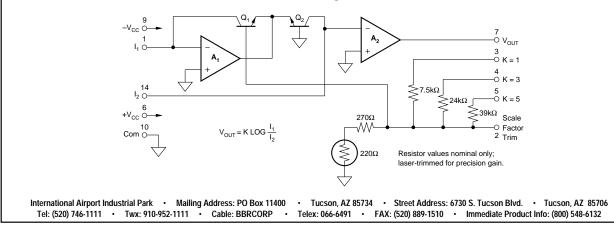
The circuit uses a specially designed compatible thinfilm monolithic integrated circuit which contains amplifiers, logging transistors, and low drift thin-film

## **APPLICATIONS**

- LOG, LOG RATIO AND ANTILOG COMPUTATIONS
- ABSORBANCE MEASUREMENTS
- DATA COMPRESSION
- OPTICAL DENSITY MEASUREMENTS
- DATA LINEARIZATION
- CURRENT AND VOLTAGE INPUTS

resistors. The resistors are laser-trimmed for maximum precision. FET input transistors are used for the amplifiers whose low bias currents (1pA typical) permit signal currents as low as 1nA while maintaining guaranteed total errors of 0.37% FSO maximum.

Because scaling resistors are self-contained, scale factors of 1V, 3V or 5V per decade are obtained simply by pin selections. No other resistors are required for log ratio applications. The LOG100 will meet its guaranteed accuracy with no user trimming. Provisions are made for simple adjustments of scale factor, offset voltage, and bias current if enhanced performance is desired.



# SPECIFICATIONS

## ELECTRICAL

 $\rm T_{_A}$  = +25°C and  $\pm \rm V_{_{CC}}$  = ±15V, after 15 minute warm-up, unless otherwise specified.

		LOG100JP			4	
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	
TRANSFER FUNCTION			$V_{OUT} = K \text{ Log } (I_1/I_2)$			
Log Conformity Error <sup>(1)</sup>	Either $I_1$ or $I_2$					
Initial	1nA to 100μA (5 decades)		0.04	0.1	%	
	1nA to 1mA (6 decades)		0.15	0.25	%	
Over Temperature	1nA to 100µA (5 decades)		0.002		%/°C	
	1nA to 1mA (6 decades)		0.001		%/°C	
K Range <sup>(2)</sup>	mix to mix (o decades)		1, 3, 5		V/decade	
Accuracy			0.3		%	
•			0.03		%/°C	
Temperature Coefficient			0.03		70/ C	
ACCURACY						
Total Error <sup>(3)</sup>	K = 1, <sup>(4)</sup> Current Input Operation					
Initial	$I_1, I_2 = 1mA$			±55	mV	
	$I_1, I_2 = 100 \mu A$			±30	mV	
	$I_1, I_2 = 10\mu A$			±25	mV	
	$I_{1}, I_{2} = 1\mu A$			±20	mV	
	$I_1, I_2 = 100nA$			±25	mV	
	$I_1, I_2 = 10nA$			±30	mV	
	$l_{1}^{2}, l_{2}^{2} = 1nA$			±37	mV	
<b>-</b> ,						
vs Temperature	$I_1, I_2 = 1mA$		±0.20		mV/°C	
	$I_1, I_2 = 100 \mu A$		±0.37		mV/°C	
	$I_1, I_2 = 10 \mu A$		±0.28		mV/°C	
	$I_{1}, I_{2} = 1\mu A$		±0.033		mV/°C	
	$I_1, I_2 = 100nA$		±0.28		mV/°C	
	$I_1, I_2 = 10nA$		±0.51		mV/°C	
	$I_1, I_2 = 1nA$		±1.26		mV/°C	
and Original a			14.0			
vs Supply	$I_1, I_2 = 1mA$		±4.3		mV/V	
	$I_1, I_2 = 100 \mu A$		±1.5		mV/V	
	$I_1, I_2 = 10 \mu A$		±0.37		mV/V	
	$I_{1}, I_{2} = 1\mu A$		±0.11		mV/V	
	$I_1, I_2 = 100nA$		±0.61		mV/V	
	$I_1, I_2 = 10nA$		±0.91		mV/V	
	$I_1, I_2 = 1nA$		±2.6		mV/V	
INPUT CHARACTERISTICS (of Amplifi	ers A, and A,)					
Offset Voltage						
Initial			±0.7	±5	mV	
vs Temperature			±80	± <b>0</b>	μV/°C	
•			100		μν/ Ο	
Bias Current				<b>F</b> ( <b>F</b> )		
Initial				5(5)	рА	
vs Temperature			Doubles Every 10°C			
	10Hz to 10kHz, RTI		3		μVrms	
	10Hz to 10kHz, RTI 10Hz to 10kHz, RTI				μVrms pArms	
Current Noise			3		1 · ·	
Current Noise AC PERFORMANCE			3		1 · ·	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10µA	10Hz to 10kHz, RTI		3		1 · ·	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10μA 1nA	10Hz to 10kHz, RTI C <sub>c</sub> = 4500pF		3 0.5 0.11		pArms kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10μA 1nA 1μA	10Hz to 10kHz, RTI C <sub>c</sub> = 4500pF C <sub>c</sub> = 150pF		3 0.5 0.11 38		pArms kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10μA 1nA 1μA 10μA	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$		3 0.5 0.11 38 27		pArms kHz kHz kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10μA 1nA 1μA 10μA 1mA	10Hz to 10kHz, RTI C <sub>c</sub> = 4500pF C <sub>c</sub> = 150pF		3 0.5 0.11 38		pArms kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10μA 1nA 1μA 10μA 1mA Step Response <sup>(6)</sup>	10Hz to 10kHz, RTI $C_{c} = 4500pF$ $C_{c} = 150pF$ $C_{c} = 150pF$ $C_{c} = 50pF$		3 0.5 0.11 38 27		pArms kHz kHz kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , I <sub>2</sub> = 10µA 1nA 1µA 10µA 1mA Step Response <sup>(6)</sup> Increasing	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$		3 0.5 0.11 38 27 45		PArms kHz kHz kHz kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA	10Hz to 10kHz, RTI $C_{c} = 4500pF$ $C_{c} = 150pF$ $C_{c} = 150pF$ $C_{c} = 50pF$		3 0.5 0.11 38 27 45 11		pArms kHz kHz kHz kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 1 $0\mu A$ 1 $m A$ Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1 $m A$ 100nA to 1 $\mu A$	10Hz to 10kHz, RTI $C_{c} = 4500pF$ $C_{c} = 150pF$ $C_{c} = 150pF$ $C_{c} = 50pF$		3 0.5 0.11 38 27 45 11 7		pArms kHz kHz kHz kHz kHz kHz μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 1 $\mu A$ 1 $0\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 100nA	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$		3 0.5 0.11 38 27 45 11		pArms kHz kHz kHz kHz kHz	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 1 $0\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 100nA Decreasing	10Hz to 10kHz, RTI $C_{c} = 4500pF$ $C_{c} = 150pF$ $C_{c} = 150pF$ $C_{c} = 50pF$		3 0.5 0.11 38 27 45 11 7 110		pArms kHz kHz kHz kHz kHz kHz μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 100nA Decreasing 1mA to 1 $\mu A$	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$		3 0.5 0.11 38 27 45 11 7 110 45		pArms kHz kHz kHz kHz kHz kHz μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 1 $\mu A$ 10nA to 1 $\mu A$ 1 $\mu A$ to 1 $\mu A$ 1 $\mu A$ to 1 $\mu A$ 1 $\mu A$ to 100nA	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$		3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 100nA Decreasing 1mA to 1 $\mu A$	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$		3 0.5 0.11 38 27 45 11 7 110 45		pArms kHz kHz kHz kHz kHz μs μs μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 1 $\mu A$ 1 $\mu A$ to 100nA 100nA to 10nA 100nA to 10nA	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$		3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs μs	
1μA 10μA 1mA Step Response <sup>(6)</sup> Increasing 1μA to 1mA 100nA to 1μA 10nA to 100nA Decreasing 1mA to 100nA 100nA to 10nA 00nA to 10nA 00nA to 10nA	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$	+10	3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs μs μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 1 $\mu A$ 1 $0\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 100nA to 1 $\mu A$ 100nA to 1 $0$ nA Decreasing 1mA to 1 $\mu A$ 1 $\mu A$ to 100nA 100nA to 10nA 100nA to 10nA EVENTIBLE COMPACTERISTICS Full Scale Output (FSO)	10Hz to 10kHz, RTI $C_c = 4500pF$ $C_c = 150pF$ $C_c = 150pF$ $C_c = 50pF$ $C_c = 150pF$	±10	3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 100nA to 1 $\mu A$ 100nA to 100nA Decreasing 1mA to 1 $\mu A$ 100nA to 100nA Decreasing 1mA to 100nA 100nA to 10nA 100nA to 10nA EXAMPLE COMPLETING Full Scale Output (FSO) Rated Output	$10Hz \text{ to } 10\text{KHz, RTI}$ $C_{c} = 4500\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 50\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$		3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $l_2 = 10\mu A$ 1nA 1 $\mu A$ 1 $0\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 1 $0$ 0nA Decreasing 1mA to 100nA Decreasing 1mA to 100nA 100nA to 10nA 00TPUT CHARACTERISTICS Full Scale Output (FSO) Rated Output Voltage	$10Hz \text{ to } 10\text{KHz, RTI}$ $C_{c} = 4500\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 50\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $I_{OUT} = \pm5\text{mA}$	±10	3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs ν V	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $l_2 = 10\muA$ 1nA 1 $\mu$ A 1	$10Hz \text{ to } 10\text{KHz, RTI}$ $C_{c} = 4500\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 50\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$		3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs μs	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 1 $0\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1mA 100nA to 1 $\mu A$ 10nA to 1 $0$ nA Decreasing 1mA to 100nA Decreasing 1mA to 100nA 100nA to 10nA 00TPUT CHARACTERISTICS Full Scale Output (FSO) Rated Output Voltage	$10Hz \text{ to } 10\text{KHz, RTI}$ $C_{c} = 4500\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 50\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $I_{OUT} = \pm5\text{mA}$	±10	3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs ν V	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $l_2 = 10\muA$ 1nA 1 $\mu$ A 1	$10Hz \text{ to } 10\text{KHz, RTI}$ $C_{c} = 4500\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 50\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $I_{OUT} = \pm5\text{mA}$	±10	3 0.5 0.11 38 27 45 11 7 110 45 20		pArms kHz kHz kHz kHz kHz μs μs μs μs μs ν V	
Current Noise AC PERFORMANCE 3dB Response <sup>(6)</sup> , $I_2 = 10\mu A$ 1nA 1 $\mu A$ 10 $\mu A$ 1mA Step Response <sup>(6)</sup> Increasing 1 $\mu A$ to 1 $\pi A$ 100nA to 1 $\mu A$ 100nA to 1 $\mu A$ 100nA to 100nA Decreasing 1mA to 1 $\mu A$ 1 $\mu A$ to 100nA Decreasing 1mA to 1 $\mu A$ 1 $\mu A$ to 100nA 100nA to 10nA <b>OUTPUT CHARACTERISTICS</b> Full Scale Output (FSO) Rated Output Voltage Current Current Limit	$10Hz \text{ to } 10\text{KHz, RTI}$ $C_{c} = 4500\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 50\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $C_{c} = 150\text{pF}$ $I_{OUT} = \pm5\text{mA}$	±10	3 0.5 0.11 38 27 45 11 7 110 45 20 550		pArms kHz kHz kHz kHz kHz μs μs μs μs μs μs ν V V v mA	



# SPECIFICATIONS (CONT)

## ELECTRICAL

 $T_{a}$  = +25°C and  $\pm V_{cc}$  = ±15V, after 15 minute warm-up, unless otherwise specified.

	LOG100JP					
PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS	
POWER SUPPLY REQUIREMENTS						
Rated Voltage			±15		VDC	
Operating Range	Derated Performance	±12		±18	VDC	
Quiescent Current			±7	±9	mA	
AMBIENT TEMPERATURE RANGE						
Specification		0		+70	°C	
Operating Range	Derated Performance	-25		+85	°C	
Storage		-40		+85	°C	

NOTES: (1) Log Conformity Error is the peak deviation from the best-fit straight line of the  $V_{out}$  vs Log  $I_{N}$  curve expressed as a percent of peak-to-peak full scale output. (2) May be trimmed to other values. See Applications section. (3) The worst-case Total Error for any ratio of  $I_{1}/I_{2}$  is the largest of the two errors when  $I_{1}$  and  $I_{2}$  are considered separately. (4) Total Error at other values of K is K times Total Error for K = 1. (5) Guaranteed by design. Not directly measurable due to amplifier's committed configuration. (6) 3dB and transient response are a function of both the compensation capacitor and the level of input current. See Typical Performance Curves.

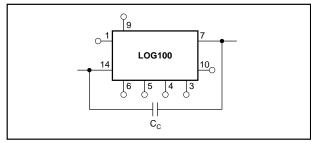
## ABSOLUTE MAXIMUM RATINGS

Supply	±18V
Internal Power Dissipation	
Input Current	10mA
Input Voltage Range	±18V
Storage Temperature Range	40°C to +85°C
Lead Temperature (soldering, 10s)	+300°C
Output Short-circuit Duration	Continuous to ground
Junction Temperature	<sup>1</sup> 175°C

## SCALE FACTOR PIN CONNECTIONS

K, V/DECADE	CONNECTIONS	
5	5 to 7	
3	4 to 7	
1.9	4 and 5 to 7	
1	3 to 7	
0.85	3 and 5 to 7	
0.77	3 and 4 to 7	
0.68	3 and 4 and 5 to 7	

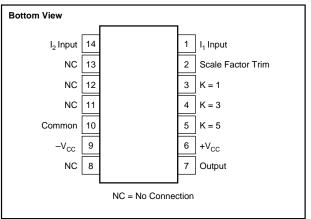
## FREQUENCY COMPENSATION



## **ORDERING INFORMATION**

MODEL	PACKAGE	SPECIFIED TEMPERATURE RANGE
LOG100JP	14-Pin Hermetic Ceramic DIP	0°C to +70°C

## **PIN CONFIGURATION**



# ELECTROSTATIC DISCHARGE SENSITIVITY

Any integral circuit can be damaged by ESD. Burr-Brown recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet published specifications.

## **PACKAGE INFORMATION**

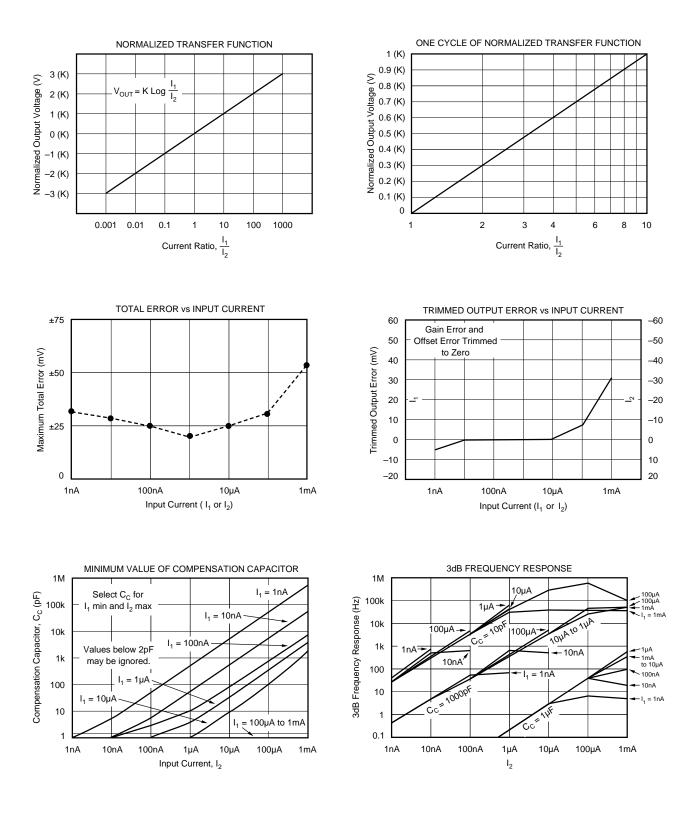
MODEL	PACKAGE	PACKAGE DRAWING NUMBER <sup>(1)</sup>
LOG100JP	14-Pin Hermetic Ceramic DIP	148(2)

NOTES: (1) For detailed drawing and dimension table, please see end of data sheet, or Appendix D of Burr-Brown IC Data Book. (2) During 1994, the package was changed from plastic to hermetic ceramic. Pinout, model number, and specifications remained unchanged. The metal lid of the new package is internally connected to common, pin 10.



# **TYPICAL PERFORMANCE CURVES**

 $\rm T_{_{A}}$  = +25°C,  $\rm V_{_{CC}}$  = ±15VDC, unless otherwise noted.





## THEORY OF OPERATION

The base-emitter voltage of a bipolar transistor is

$$V_{BE} = V_T \ \ell \ n \ \frac{I_C}{I_S}$$
 where:  $V_T = \frac{KT}{q}$ 

K = Boltzman's constant =  $1.381 \times 10^{-23}$ 

- T = Absolute temperature in degrees Kelvin
- $q = Electron charge = 1.602 \times 10^{-19} Coulombs$

 $I_c = Collector current$ 

 $I_s$  = Reverse saturation current

From the circuit in Figure 1, we see that

$$\mathbf{V}_{\rm OUT}' = \mathbf{V}_{\rm BE_1} - \mathbf{V}_{\rm BE_2} \tag{2}$$

Substituting (1) into (2) yields

$$V_{OUT}' = V_{T_1} \ell n \, \frac{I_1}{I_{S_1}} - V_{T_2} \, \ell n \, \frac{I_1}{I_{S_2}}$$
(3)

If the transistors are matched and isothermal and  $V_{T1} = V_{T2}$ , then (3) becomes:

$$V_{OUT}' = V_T \left[ \ell n \, \frac{l_1}{l_s} - \ell n \, \frac{l_2}{l_s} \right]$$
 (4)

$$V_{OUT}' = V_T \ell n \frac{I_1}{I_2}$$
 and since (5)

$$\ell \mathbf{n} \ \mathbf{x} = 2.3 \ \log_{10} \mathbf{x} \tag{6}$$

$$\mathbf{V}_{\text{OUT}}' = \mathbf{n} \ \mathbf{V}_{\text{T}} \log \ \frac{\mathbf{I}_{1}}{\mathbf{I}_{2}} \tag{7}$$

where 
$$n = 2.3$$
 (8)

also

$$\mathbf{V}_{\text{OUT}} = \mathbf{V}_{\text{OUT}}' \frac{\mathbf{R}_1 + \mathbf{R}_2}{\mathbf{R}_1}$$
(9)

$$= \frac{\mathbf{R}_1 + \mathbf{R}_2}{\mathbf{R}} \mathbf{n} \mathbf{V}_{\mathrm{T}} \log \frac{\mathbf{I}_1}{\mathbf{I}}$$
(10)

or

$$\mathbf{V}_{\text{OUT}} = \mathbf{K} \log \frac{\mathbf{I}_1}{\mathbf{I}_2} \tag{11}$$

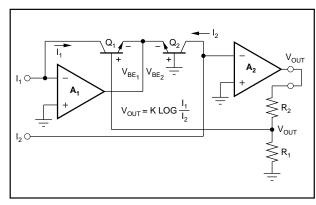


FIGURE 1. Simplified Model of Log Amplifier.

It should be noted that the temperature dependance associated with  $V_T = KT/q$  is compensated by making  $R_1$  a temperature sensitive resistor with the required positive temperature coefficient.

## **DEFINITION OF TERMS**

## TRANSFER FUNCTION

The ideal transfer function is  $V_{OUT} = K \log \frac{I_1}{I_2}$ where:

- K = the scale factor with units of volts/decade
- $I_1$  = numerator input current
- $I_2$  = denominator input current.

#### ACCURACY

(1)

Accuracy considerations for a log ratio amplifier are somewhat more complicated than for other amplifiers. The reason is that the transfer function is nonlinear and has two inputs, each of which can vary over a wide dynamic range. The accuracy for any combination of inputs is determined from the total error specification.

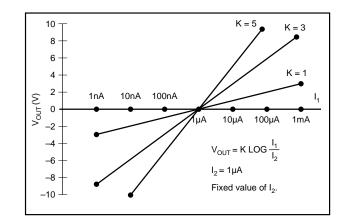


FIGURE 2. Transfer Function with Varying K and I<sub>1</sub>.

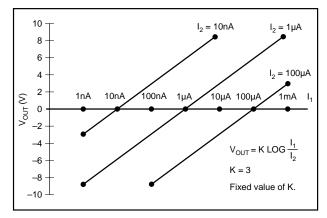


FIGURE 3. Transfer Function with Varying  $I_2$  and  $I_1$ .



#### TOTAL ERROR

The total error is the deviation (expressed in mV) of the actual output from the ideal output of  $V_{OUT} = K \log (I_1/I_2)$ . Thus,

$$V_{OUT (ACTUAL)} = V_{OUT (IDEAL)} \pm Total Error$$

It represents the sum of all the individual components of error normally associated with the log amp when operated in the current input mode. The worst-case error for any given ratio of  $I_1/I_2$  is the largest of the two errors when  $I_1$  and  $I_2$  are considered separately.

Example:

 $I_1$  varies over a range of 10nA to 1µA and  $I_2$  varies from 100nA to 10µA. What is the maximum error?

Table I shows the maximum errors for each decade combination of  $I_1$  and  $I_2$ .

	I <sub>1</sub> (maximum error) <sup>(1)</sup>			
ω(-		10nA (30mV)	100nA (25mV)	1μΑ (20mV)
n errol	100nA	0.1	1	10
	(25mV)	(30mV)	(25mV)	(25mV)
l₂ (maximum error)⑴	1μΑ	0.01	0.1	1
	(20mV)	(30mV)	(25mV)	(20mV)
l <sub>2</sub> (m	10μΑ	0.001	0.01	0.1
	(25mV)	(30mV)	(25mV)	(25mV)
NOTE: (1) Maximum errors are in parenthesis.				

TABLE I.  $I_1/I_2$  and Maximum Errors.

Since the largest value of  $I_1/I_2$  is 10 and the smallest is 0.001, K is set at 3V per decade so the output will range from +3V to -9V. The maximum total error occurs when  $I_1 = 10$ nA and is equal to K x 30mV. This represents a 0.75% of peak-to-peak FSO error 3 x 0.030/12 x 100% = 0.75% where the full scale output is 12V (from +3V to -9V).

### ERRORS RTO AND RTI

As with any transfer function, errors generated by the function itself may be Referred-to-Output (RTO) or Referred-to-Input (RTI). In this respect, log amps have a unique property:

Given some error voltage at the log amp's output, that error corresponds to a constant percent of the input regardless of the actual input level.

Refer to: Yu Jen Wong and William E. Ott, "Function Circuits: Design & Applications", McGraw-Hill Book, 1976.

#### LOG CONFORMITY

Log conformity corresponds to linearity when  $V_{OUT}$  is plotted versus  $I_1/I_2$  on a semilog scale. In many applications, log conformity is the most important specification. This is true because bias current errors are negligible (1pA compared to input currents of 1nA and above) and the scale factor and offset errors may be trimmed to zero or removed by system calibration. This leaves log conformity as the major source of error.



Log conformity is defined as the peak deviation from the best-fit straight line of the  $V_{OUT}$  versus log  $(I_1/I_2)$  curve. This is expressed as a percent of peak-to-peak full scale output. Thus, the nonlinearity error expressed in volts over m decades is

$$V_{OUT (NONLIN)} = K \ 2Nm \ V \tag{12}$$

where N is the log conformity error, in percent.

#### INDIVIDUAL ERROR COMPONENTS

The ideal transfer function with current input is

$$V_{OUT} = K \text{ Log } \frac{I_1}{I_2}$$
(13)

The actual transfer function with the major components of error is

$$V_{OUT} = K (1 \pm \Delta K) \log \frac{I_1 - I_{B_1}}{I_2 - I_{B_2}} \pm K 2Nm \pm V_{OS OUT}$$
(14)

The individual component of error is

- $\Delta K$  = scale factor error (0.3%, typ)
- $I_{B1}$  = bias current of  $A_1$  (1pA, typ)
- $I_{B2}$  = bias current of  $A_2$  (1pA, typ)
- N = log conformity error (0.05%, 0.1%, typ)
- $V_{OS OUT}$  = output offset voltage (1mV, typ)
- m = number of decades over which N is specified: 0.05% for m = 5, 0.1% for m = 6

Example: what is the error with K = 3 when

 $I_1 = 1\mu A$  and  $I_2 = 100nA$ 

$$V_{\text{OUT}} = 3(1 \pm 0.003) \log \frac{10^{-6} - 10^{-12}}{10^{-7} - 10^{-12}} \pm 3(2)(0.0005)5 \pm 1 \text{mV}$$
(15)

$$\approx 3.009 \log \frac{10^{-6}}{10^{-7}} + 0.015 + 0.001 \tag{16}$$

$$= 3.009 (1) + 0.015 + 0.001$$
(17)

$$= 3.025 V$$
 (18)

Since the ideal output is 3.000V, the error as a percent of reading is

% error = 
$$\frac{0.025}{3}$$
 x 100% = 0.83% (19)

For the case of voltage inputs, the actual transfer function is

$$V_{OUT} = K(1 \pm \Delta K) \log \frac{\frac{V_1}{R_1} - I_{B_1} \pm \frac{E_{OS_1}}{R_1}}{\frac{V_2}{R_2} - I_{B_2} \pm \frac{E_{OS_2}}{R_2}} \pm K \ 2Nm \ \pm V_{OS \ OUT}$$
(20)

#### FREQUENCY RESPONSE

The 3dB frequency response of the LOG100 is a function of the magnitude of the input current levels and of the value of the frequency compensation capacitor. See Typical Performance Curves for details. The frequency response curves are shown for constant DC  $I_1$  and  $I_2$  with a small signal AC current on one of them.

The transient response of the LOG100 is different for increasing and decreasing signals. This is due to the fact that a log amp is a nonlinear gain element and has different gains at different levels of input signals. Frequency response decreases as the gain increases.

## **GENERAL INFORMATION**

## INPUT CURRENT RANGE

The stated input range of 1nA to 1mA is the range for specified accuracy. Smaller or larger input currents may be applied with decreased accuracy. Currents larger than 1mA result in increased nonlinearity. The 10mA absolute maximum is a conservative value to limit the power dissipation in the output stage of  $A_1$  and the logging transistor. Currents below 1nA will result in increased errors due to the input bias currents of  $A_1$  and  $A_2$  (1pA typical). These errors may be nulled. See Optional Adjustments section.

#### FREQUENCY COMPENSATION

Frequency compensation for the LOG100 is obtained by connecting a capacitor between pins 7 and 14. The size of the capacitor is a function of the input currents as shown in the Typical Performance Curves. For any given application, the smallest value of the capacitor which may be used is determined by the maximum value at  $I_2$  and the minimum value of  $I_1$ . Larger values of  $C_c$  will make the LOG100 more stable, but will reduce the frequency response.

### SETTING THE REFERENCE CURRENT

When the LOG100 is used as a straight log amplifier  $I_2$  is constant and becomes the reference current in the expression

$$V_{OUT} = K \log \frac{I_1}{I_{PEF}}$$
(21)

 $I_{REF}$  can be derived from an external current source (such as shown in Figure 4), or it may be derived from a voltage source with one or more resistors.

When a single resistor is used, the value may be quite large when  $I_{REF}$  is small. If  $I_{REF}$  is 10nA and +15V is used

$$R_{\text{REF}} = \frac{15\text{ V}}{10\text{nA}} = 1500\text{M}\Omega.$$

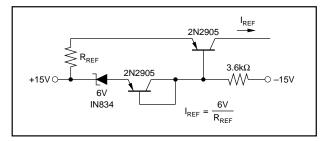


FIGURE 4. Temperature-Compensated Current Reference.

A voltage divider may be used to reduce the value of the resistor. When this is done, one must be aware of possible errors caused by the amplifier's input offset voltage. This is shown in Figure 5.

In this case the voltage at pin 14 is not exactly zero, but is equal to the value of the input offset voltage of  $A_1$ , which ranges from zero to  $\pm 5$ mV.  $V_T$  must be kept much larger than 5mV in order to make this effect negligible. This concept also applies to pin 1.

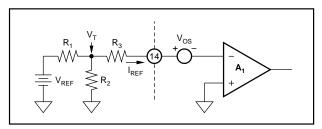


FIGURE 5. "T" Network for Reference Current.

## **OPTIONAL ADJUSTMENTS**

The LOG100 will meet its specified accuracy with no user adjustments. If improved performance is desired, the following optional adjustments may be made.

### **INPUT BIAS CURRENT**

The circuit in Figure 6 may be used to compensate for the input bias currents of  $A_1$  and  $A_2$ . Since the amplifiers have FET inputs with the characteristic bias current doubling every 10°C, this nulling technique is practical only where the temperature is fairly stable.

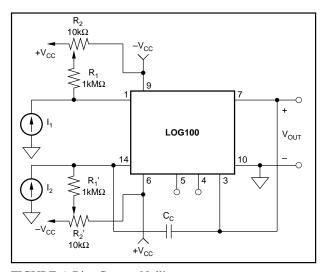


FIGURE 6. Bias Current Nulling.

## **OUTPUT OFFSET**

The output offset may be nulled with the circuit in Figure 7.  $I_1$  and  $I_2$  are set equal at some convenient value in the range of 100nA to 100 $\mu$ A.  $R_1$  is then adjusted for zero output voltage.



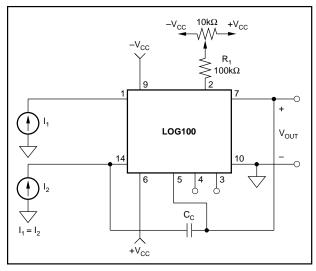


FIGURE 7. Output Offset Nulling.

#### ADJUSTMENTS OF SCALE FACTOR K

The value of K may be changed by increasing or decreasing the voltage divider resistor normally connected to the output, pin 7. To increase K put resistance in series between pin 7 and the appropriate scaling resistor pin (3, 4 or 5). To decrease K place a parallel resistor between pin 2 and either pin 3, 4 or 5.

## **APPLICATION INFORMATION**

## WIRING PRECAUTIONS

In order to prevent frequency instability due to lead inductance of the power supply lines, each power supply should be bypassed. This should be done by connecting a  $10\mu$ F tantalum capacitor in parallel with a 1000pF ceramic capacitor from the  $+V_{CC}$  and  $-V_{CC}$  pins to the power supply common. The connection of these capacitors should be as close to the LOG100 as practical.

#### CAPACITIVE LOADS

Stable operation is maintained with capacitive loads of up to 100pF, typically. Higher capacitive loads can be driven if a  $22\Omega$  carbon resistor is connected in series with the LOG100's output. This resistor will, of course, form a voltage divider with other resistive loads.

## **CIRCUIT PROTECTION**

The LOG100 can be protected against accidental power supply reversal by putting a diode (1N4001 type) in series with each power supply line as shown in Figure 8. This precaution is necessary only in power systems that momentarily reverse polarity during turn-on or turn-off. If this protection circuit is used, the accuracy of the LOG100 will be degraded slightly by the voltage drops across the diodes as determined by the power supply sensitivity specification.

The LOG100 uses small geometry FET transistors to achieve the low input bias currents. Normal FET handling

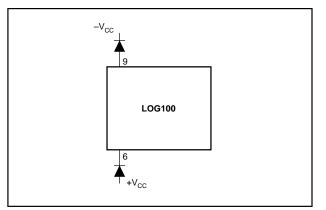


FIGURE 8. Reverse Polarity Protection.

techniques should be used to avoid damage caused by low energy electrostatic discharge (ESD).

### LOG RATIO

One of the more common uses of log ratio amplifiers is to measure absorbance. A typical application is shown in Figure 9.

Absorbance of the sample is 
$$A = \log \frac{\lambda_1'}{\lambda_1}$$
 (22)

If 
$$\lambda_2 = \lambda_1$$
 and  $D_1$  and  $D_2$  are matched  $A \propto K \log \frac{I_1}{I_2}$ . (23)

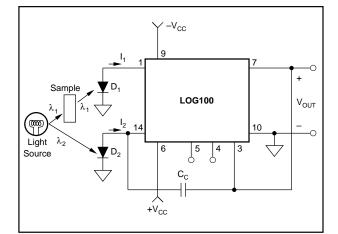


FIGURE 9. Absorbance Measurement.

#### DATA COMPRESSION

In many applications the compressive effects of the logarithmic transfer function is useful. For example, a LOG100 preceding an 8-bit analog-to-digital converter can produce equivalent 20-bit converter operation.

#### SELECTING OPTIMUM VALUES OF I, AND K

In straight log applications (as opposed to log ratio), both K and  $I_2$  are selected by the designer. In order to minimize errors due to output offset and noise, it is normally best to



scale the log amp to use as much of the  $\pm 10V$  output range as possible. Thus, with the range of  $I_1$  from  $I_{1 \text{ MIN}}$  to  $I_{1 \text{ MAX}}$ ;

For 
$$I_{1 MAX} + 10V = K \log I_{1 MAX} / I_2$$
 (24)

For 
$$I_{1 \text{ MIN}}$$
 – 10V = K log  $I_{1 \text{ MIN}}/I_2$  (25)

Addition of these two equations and solving for  $I_2$  shows that its optimum value,  $I_{2\ OPT}$ , is the geometric mean of  $I_{1\ MAX}$  and  $I_{1\ MIN}$ .

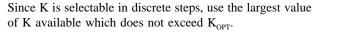
$$\mathbf{I}_{2 \text{ OPT}} = \sqrt{\mathbf{I}_{1 \text{ MAX}} \mathbf{X} \mathbf{I}_{1 \text{ MIN}}}$$
(26)

$$K_{OPT} = \frac{10}{\log \frac{I_{1 MAX}}{I_{2 OPT}}}$$
(27)

P<sub>1</sub> + + P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> P<sub>1</sub> P<sub>2</sub> P<sub>1</sub> 

FIGURE 10. Current Inverter.

#### **ANTILOG CONFIGURATION** (an implicit technique)



## **NEGATIVE INPUT CURRENTS**

The LOG100 will function only with positive input currents (conventional current flow into pins 1 and 14). Some current sources (such as photomultiplier tubes) provide negative input currents. In such situations, the circuit in Figure 10 may be used.<sup>(1)</sup>

## **VOLTAGE INPUTS**

The LOG100 gives the best performance with current inputs. Voltage inputs may be handled directly with series resistors, but the dynamic input range is limited to approximately three decades of input voltage by voltage noise and offsets. The transfer function of equation (20) applies to this configuration.

NOTE: (1) More detailed information may be found in "Properly Designed Log Amplifiers Process Bipolar Input Signals" by Larry McDonald, EDN, 5 Oct. 80, pp 99–102.

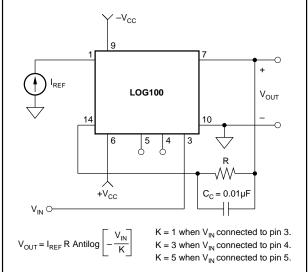


FIGURE 11. Connections for Antilog Function.

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